

# SAR Exemption Evaluation Report

Product Name	:	EZ-BLE Module with HomeKit
Model No.	:	CYBLE-413136-01
		CYBLE-473142-01
		CYBLE-413149-01
		CYBLE-473148-01
FCC ID	:	WAP3136

Applicant : Cypress Semiconductor Address : 198 Champion Ct, San Jose, California 95134 United States

Date of Receipt	:	Mar. 30, 2018
Test Date	:	Mar. 30, 2018 ~ Apr. 11, 2018
Issued Date	:	Apr. 13, 2018
Report No.	:	1832181R-RF-US-P20V02
Report Version	:	V 1.0

The test results relate only to the samples tested.

The test results shown in the test report are traceable to the national/international standard through the calibration of the equipment and evaluated measurement uncertainty herein.

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# Test Report Certification Issued Date : Apr. 13, 2018

Issued Date : Apr. 13, 2018 Report No. : 1832181R-RF-US-P20V02

Product Name	:	EZ-BLE Module with HomeKit						
Applicant	:	Cypress Semiconductor						
Address	:	198 Champion Ct, San Jose, California 95134 United States						
Manufacturer	:	Wujiang Sigmatron Electronics Co., Ltd						
Address Model No.	:	386 Huahong Rd, Wujiang, Suzhou, Jiangsu, Chi CYBLE-413136-01						
		CYBLE-473142-01						
		CYBLE-413149-01						
		CYBLE-473148-01						
FCC ID	:	WAP3136						
EUT Voltage	:	DC 3.0V-3.6V						
Applicable Standard	:	KDB 447498 D01v06						
Test Result	:	Complied						
Performed Location	:	DEKRA Testing & Certification (Suzhou) Co., Ltd. No.99 Hongye Rd., Suzhou Industrial Park, Suzhou 215006, Jiangsu, China TEL: +86-512-6251-5088 / FAX: +86-512-6251-509 FCC Registration Number: CN1199;						
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		(Senior Engineer: Frank He)						
Approved By	:	Harry zhao						
		(Engineering Manager : Harry Zhao )						



## 1. RF Exposure Evaluation

# 1.1. Limits

#### According to KDB 447498 D01 General RF Exposure Guidance v06

#### 4.3.1 Standalone SAR test exclusion considerations

1) The 1-g and 10-g SAR test exclusion thresholds for 100 MHz to 6 GHz at test separation distances  $\leq$  50 mm are determined by:

[(max. power of channel, including tune-up tolerance, mW)/(min. test separation distance, mm)]  $\cdot [\sqrt{f(GHz)}] \le 3.0$  for 1-g SAR and  $\le 7.5$  for 10-g extremity SAR,where

- f(GHz) is the RF channel transmit frequency in GHz
- Power and distance are rounded to the nearest mW and mm before calculation
- The result is rounded to one decimal place for comparison
- 3.0 and 7.5 are referred to as the numeric thresholds in the step 2 below

The test exclusions are applicable only when the minimum test separation distance is  $\leq$  50 mm and for transmission frequencies between 100 MHz and 6 GHz. When the minimum test separation distance is < 5 mm, a distance of 5 mm according to 5) in section 4.1 is applied to determine SAR test exclusion.

2) At 100 MHz to 6 GHz and for test separation distances > 50 mm, the SAR test exclusion threshold is determined according to the following, and as illustrated in Appendix B:

a) [Power allowed at numeric threshold for 50 mm in step 1) + (test separation distance - 50 mm)  $\cdot$  (f(MHz)/150)] mW, at 100 MHz to 1500 MHz

b) [Power allowed at numeric threshold for 50 mm in step 1) + (test separation distance - 50 mm) $\cdot$ 10] mW at > 1500 MHz and ≤ 6 GHz

3) The 1-g and 10-g SAR test exclusion thresholds for below 100 MHz at test separation distances  $\leq$  50 mm are determined by:

a) The power threshold at the corresponding test separation distance at 100 MHz in step 2) is

multiplied by [1 + log(100/f(MHz))] for test separation distances > 50 mm and < 200 mm

b) The power threshold determined by the equation in a) for 50 mm and 100 MHz is multiplied by ½ for test separation distances ≤ 50 mm

c) SAR measurement procedures are not established below 100 MHz. When SAR test exclusion cannot be applied, a KDB inquiry is required to determine SAR evaluation requirements for any test results to be acceptable. Note: when the minimum test separation distance is < 5 mm, a distance of 5 mm is applied to determine SAR test exclusion.



## 1.2. Test Procedure

Software provided by client enabled the EUT to transmit and receive data at lowest, middle and highest channel individually.

The temperature and related humidity:  $18^\circ\!\mathbb{C}\,and\,78\%\,$  RH.

# 1.3. Test Result of RF Exposure Evaluation

Product	•	EZ-BLE Module with HomeKit
Test Item	:	RF Exposure Evaluation
Test Site	:	AC-6

#### • Antenna Gain:

Model No.	N/A								
Antenna manufacturer	N/A								
Antenna Delivery	$\boxtimes$	□ 1*TX+1*RX □ 2*TX+2*RX □ 3*TX+3*RX							
Antenna technology	SISO								
		MIMO		Basic					
				CDD					
				Sectorized					
				Beam-forming					
Antenna Type		External		Dipole					
				Sectorized					
	X	Internal		PIFA					
			$\boxtimes$	PCB					
				Ceramic Chip Antenna					
				Metal plate type F antenna					
Antenna Technology	Ant Gain								
		(dBi)							
SISO	-0.5								



Based on The 1-g and 10-g SAR test exclusion thresholds for 100 MHz to 6 GHz at test separation distances  $\leq$  50 mm and the formula below:

Estimated SAR=
$$\sqrt{f(GHz)} * \frac{(Max Power of channel, mW)}{Min. Separation Distance, mm}$$

Maximum conducted tune-up power is 8.4dBm:

	Band Exposure Pma: Condition (dBm	Dmox	Pmax	Distance			Stand-alone	
Dand					f(GHz)	calculation	Test	
Band		(dDm)	(70)(()	(mm)		result	exclusion	SAR Test
		(автт)	(mw)				threshold	
BT	Body	8.4	6.918	5	2.44	2.16	3.00	No

Conclusion: 2400MHz-2480MHz SAR was not required.

——— The End